



**CAPACITORS, FIXED, CHIPS, CERAMIC
DIELECTRIC, TYPE II**

BASED ON TYPE 0603

ESCC Detail Specification No. 3009/038

Issue 7	June 2026
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DOCUMENTATION CHANGE NOTICE

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DCR No.	CHANGE DESCRIPTION
1791	Specification updated to incorporate changes per DCR.

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1 GENERAL

1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, and test and inspection data for the component type variants and/or the range of components specified below. It supplements the requirements of, and shall be read in conjunction with, the ESCC Generic Specification listed under Applicable Documents.

1.2 APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:

- (a) ESCC Generic Specification No. [3009](#).

1.3 TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESCC Basic Specification No. [21300](#) shall apply.

1.4 THE ESCC COMPONENT NUMBER AND COMPONENT TYPE VARIANTS

1.4.1 The ESCC Component Number

The ESCC Component Number shall be constituted as follows:

Example: 300903801102KC

- Detail Specification Reference: 3009038
- Component Type Variant Number: 01 (as required)
- Characteristic code: Capacitance Value (1000pF): 102 (as required)
- Characteristic code: Capacitance Tolerance ($\pm 5\%$): K (as required)
- Rating code: Rated Voltage (50V): C (as required)

1.4.1.1 Characteristics and Ratings Codes

Characteristics and ratings to be codified as part of the ESCC Component Number shall be as follows:

- (a) Rated Capacitance Value, C_n , expressed by means of the following codes in accordance with ESCC Basic Specification No. 21700. The unit quantity shall be picofarad (pF).

Capacitance Value C_n (pF)	Code
XX 10 ¹	XX1
XX 10 ²	XX2
XX 10 ³	XX3
XX 10 ⁴	XX4

- (b) Capacitance Tolerance expressed by the following codes in accordance with ESCC Basic Specification No. 21700:

Tolerance (± %)	Code Letter
5	J
10	K
20	M

- (c) Rated Voltage, U_R , expressed by the following codes:

Rated Voltage U_R (V)	Code Letter
10	Y
16	X
25	A
50	C
100	E
200	G

1.4.2 Component Type Variants and Range of Components

The component type variants and range of components applicable to this specification are as follows:

Variant Number	Style	Capacitance Range, Tolerance, Rated Voltage	Terminal Material and Finish		Weight Max (g)
			End Terminations	Termination Finish	
01	0603	See Note 1	Ag/Pd	No finish (Note 2)	0.1
03	0603	See Note 1	Ag/Pd/Pt	No finish (Note 2)	0.1
05	0603	See Note 1	Ag + Ni barrier	Sn60, Sn62 or Sn63 solder dip	0.1
06	0603	See Note 1	Ag + Ni barrier	Sn/Pb plating (Note 3)	0.1
07 (Note 4)	0603	See Note 1	Ag + Ni barrier	Sn/Pb plating (Note 3)	0.1
08	0603	See Note 1	Ag + Ni barrier	Au plating (Note 2)	0.1
09 (Note 4)	0603	See Note 1	Ag/Pd	No finish (Note 2)	0.1
10 (Note 4)	0603	See Note 1	Ag/Pd/Pt	No finish (Note 2)	0.1
11 (Note 4)	0603	See Note 1	Ag + Ni barrier	Au plating (Note 2)	0.1

NOTES:

- Available rated voltages, capacitance values and tolerances are as follows:

Rated Voltage U_R (V)	Capacitance Range C_n (pF)	
	Min	Max
200	100	3900
100	270	12000
50	270	22000
25	270	33000
16	270	100000
10	270	120000

Available Capacitance values for each Rated Voltage are as defined by the E6 to E24 series; however, any capacitance value within each specified capacitance range may be available on request.

Capacitance tolerances available are: 5% 10% 20%.

- Variants 01, 03, 08, 09, 10 and 11 are not suitable for solder assembly methods. They shall be assembled using glue or wire bond techniques.
- Sn/Pb plating with tin content of 50% minimum and 97% maximum, remainder lead.
- Variants 07, 09, 10 and 11 have X7R dielectric; see Para. 2.3.2 High and Low Temperatures Electrical Measurements.

1.5 MAXIMUM RATINGS

The maximum ratings shall not be exceeded at any time during use or storage.

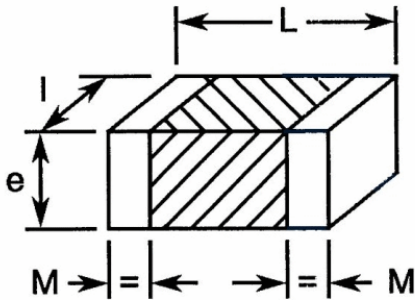
Maximum ratings shall only be exceeded during testing to the extent specified in this specification and when stipulated in Test Methods and Procedures of the ESCC Generic Specification.

Characteristics	Symbols	Maximum Ratings	Units	Remarks
Rated Voltage	U_R	10, 16, 25, 50, 100, 200	V	Note 1
Operating Temperature Range	T_{op}	-55 to +125	°C	Without derating. T_{amb}
Storage Temperature Range	T_{stg}	-55 to +125	°C	
Soldering Temperature	T_{sol}	+260	°C	Note 2

NOTES:

1. As required; See Para. 1.4.2.
2. Duration 10 seconds maximum.

1.6 PHYSICAL DIMENSIONS



Symbols	Dimensions (mm)			
	Variants 01, 03, 06, 07, 08, 09, 10, 11		Variant 05	
	Min	Max	Min	Max
L	1.4	1.8	1.4	2.3
l	0.6	1	0.6	1.5
e	-	1	-	1.5
M	0.1	0.5	0.1	0.5

1.7 FUNCTIONAL DIAGRAM



2 REQUIREMENTS

2.1 GENERAL

The complete requirements for procurement of the components specified herein are as stated in this specification and the ESCC Generic Specification. Permitted deviations from the Generic Specification, applicable to this specification only, are listed below.

Permitted deviations from the Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESCC requirement and do not affect the component's reliability, are listed in the appendices attached to this specification.

2.1.1 Deviations from the Generic Specification

2.1.1.1 *Deviations from Qualification and Periodic Tests - Chart F4*

(a) Solderability: not applicable to Variants 01, 03, 08, 09, 10 and 11.

2.2 MARKING

The marking shall be in accordance with the requirements of ESCC Basic Specification No. [21700](#) and as follows.

The information to be marked on the component or its primary package shall be:

- (a) The ESCC qualified components symbol (for ESCC qualified components only).
- (b) The ESCC Component Number (see Para. 1.4.1).
- (c) Traceability information.

2.3 ELECTRICAL MEASUREMENTS AT ROOM, HIGH AND LOW TEMPERATURES

Electrical measurements shall be performed at room, high and low temperatures.

2.3.1 Room Temperature Electrical Measurements

The measurements shall be performed at $T_{amb} = +22 \pm 3^{\circ}C$.

Characteristics	Symbols	Test Method and Conditions	Tolerance (± %)	Limits		Units
				Min	Max	
Capacitance (Note 1)	C _A	ESCC No. 3009	5	0.95C _n	1.05C _n	pF
			10	0.9C _n	1.1C _n	
			20	0.8C _n	1.2C _n	
Tangent of Loss Angle	tgδ	ESCC No. 3009	All	-	250 x10 ⁻⁴	-
Insulation Resistance	R _i	ESCC No. 3009 For C _n ≤ 10000pF For C _n > 10000pF	All	100	-	GΩ
				1000	-	GΩ.nF
Voltage Proof	VP	ESCC No. 3009	All	2.5U _R	-	V

NOTES:

1. Capacitance limits may be adjusted to take into account capacitance ageing, as specified in the Generic Specification.

2.3.2 High and Low Temperatures Electrical Measurements

Characteristics	Symbols	Test Method and Conditions (Note 1)	Limits		Units
			Min	Max	
Insulation Resistance	R _i	ESCC No. 3009 T _{amb} = +125 ±2°C Note 2			
		For C _n ≤ 10000pF For C _n > 10000pF	10 100	- -	GΩ GΩ.nF
Temperature Characteristic	TC	ESCC No. 3009 T _{amb} = -55 ±2°C, +20 ±2°C, +125 ±2°C Note 3			%
		For V _T = no voltage applied: All Variants: For V _T = U _R : Variants 01, 03, 05, 06, 08: Variants 07, 09, 10, 11:	-20 -30	+20 +20	

NOTES:

1. The measurements shall be performed on a sample of 5 components from each manufacturing lot with 0 failures allowed. In the event of any failure a 100% inspection may be performed.
2. Guaranteed but not tested during Chart F3 of the Generic Specification; only tested in Temperature Characterisation during Chart F4 of the Generic Specification.
3. In the case of a 100% inspection, a 1% total percent defective is allowed.
4. X7R dielectric. Temperature Characteristic for V_T = U_R is typically -60%. Temperature Characteristic measurements with rated voltage applied are not required.

2.4 INTERMEDIATE AND END-POINT ELECTRICAL MEASUREMENTS

Unless otherwise specified, the measurements shall be performed at $T_{amb} = +22 \pm 3^{\circ}C$.

Unless otherwise specified the test methods and test conditions shall be as per the corresponding test defined in Para. 2.3.1 Room Temperature Electrical Measurements.

Test Reference per ESCC No. 3009	Characteristics	Symbols	Limits		Units
			Min	Max	
Mounting Final Measurements	Capacitance Tangent of Loss Angle Insulation Resistance	C_A $tg\delta$ R_I	Record Values - 250×10^{-4} Note 1		-
Rapid Change of Temperature Initial Measurements	Capacitance	C_A	Notes 1, 2		
Final Measurements	Capacitance Change in Capacitance Tangent of Loss Angle	C_A $\Delta C_A/C_A$ $tg\delta$	-10 -	Note 1 +10 500×10^{-4}	% -
Steady State Humidity (85/85) Initial Measurements	Capacitance	C_A	Note 1		
Final Measurements (1000 hours)	Capacitance Change in Capacitance Tangent of Loss Angle Insulation Resistance (Note 3): For $C_n \leq 10000pF$ For $C_n > 10000pF$	C_A $\Delta C_A/C_A$ $tg\delta$ R_I R_I	-10 - 3 30	Note 1 +10 500×10^{-4} - -	% - GΩ GΩ.nF
Operating Life Initial Measurements	Capacitance	C_A	Notes 1, 2		
Intermediate Measurements (1000 hours) (Note 4)	Capacitance Change in Capacitance Insulation Resistance: For $C_n \leq 10000pF$ For $C_n > 10000pF$	C_A $\Delta C_A/C_A$ R_I R_I	-15 -15 10 100	Note 1 +15 - -	% GΩ GΩ.nF
Final Measurements (1000 or 2000 hours) (Note 5)	Capacitance Change in Capacitance Tangent of Loss Angle Insulation Resistance: For $C_n \leq 10000pF$ For $C_n > 10000pF$ Voltage Proof	C_A $\Delta C_A/C_A$ $tg\delta$ R_I R_I VP	-15 - 10 100 $2.5U_R$	Note 1 +15 500×10^{-4} - -	% - GΩ GΩ.nF V

Test Reference per ESCC No. 3009	Characteristics	Symbols	Limits		Units
			Min	Max	
Temperature Characterisation	Insulation Resistance at $T_{amb} = +125 \pm 2^{\circ}C$	R_I	Note 6		
	Temperature Characteristic	TC	Note 6		
Robustness of Terminations Final Measurements	Capacitance	C_A	Note 1		

NOTES:

1. As specified in Para. 2.3.1 Room Temperature Electrical Measurements.
2. Capacitance values recorded during Mounting may be used as initial measurements.
3. Test conditions for Insulation Resistance shall be as specified in Steady State Humidity in the ESCC Generic Specification.
4. Intermediate measurements are optional at the Manufacturer's discretion.
5. 1000 hours is applicable to Periodic Testing for extension of qualification. 2000 hours is applicable to Qualification Testing, and to Periodic Testing for renewal of qualification after lapse.
6. As specified in Para. 2.3.2 High and Low Temperatures Electrical Measurements.

2.5

BURN-IN

The requirements for Burn-in are specified in the ESCC Generic Specification. The following conditions shall also apply:

- After Burn-in, the components shall be removed from the chamber and allowed to cool under normal atmospheric conditions for recovery for 24 hours minimum.

APPENDIX A**AGREED DEVIATIONS FOR EXXELIA TECHNOLOGIES (F)**

Items Affected	Description of Deviations
Para. 2.1.1 Deviations from the Generic Specification: Screening Tests - Chart F3	Burn-in: Due to the use of components of varying designs to cover the available range of components as listed in REP005 (ESCC QPL), for any particular component, the Applied Voltage for Burn-in shall be as specified in the PID as agreed with the ESCC Executive, with a minimum value of 2 times the Rated Voltage (DC).